

**Search Notes**

Application/Control No.

10/673,466

Examiner

Thien F. Tran

Applicant(s)/Patent under  
Reexamination

SHIMIZU ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	405, 406	6/29/2005	TT
257	410, 411	6/29/2005	TT
438	216, 261	6/29/2005	TT
438	591	6/29/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/29/2005	TT